

SPECIFICATIONS

| | |
|----------------------|-------------------------------|
| Customer | |
| Product Name | Multi-layer Chip Ferrite Bead |
| Sunlord Part Number | EPZ4532D900-9R0T |
| Customer Part Number | |

New Released, Revised]

SPEC No.: EPZ01250006

| Rev. | Effective Date | Changed Contents | Change Reasons | Approved By |
|------|----------------|------------------|----------------|-------------|
| 01 | Sep.02,2025 | New release | / | Hai Guo |

【This SPEC is total 9 pages including specifications.】

【ROHS Compliant Parts 】

| Approved By | Checked By | Issued By |
|---|---|--|
|  |  |  |

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【For Customer approval Only】

Date: _____

Qualification Status: Full Restricted Rejected

| Approved By | Verified By | Re-checked By | Checked By |
|-------------|-------------|---------------|------------|
| | | | |

Comments:

Caution

All products listed in this specification are developed, designed and intended for use in general electronics equipment. The products are not designed or warranted to meet the requirements of the applications listed below, whose performance and/or quality require especially high reliability, or whose failure, malfunction or trouble might directly cause damage to society, person, or property. Please understand that we are not responsible for any damage or liability caused by use of the products in any of the applications below. Please contact us for more details if you intend to use our products in the following applications.

1. Aircraft equipment
2. Aerospace equipment
3. Undersea equipment
4. nuclear control equipment
5. military equipment
6. Power plant equipment
7. Medical equipment
8. Transportation equipment (automobiles, trains, ships,etc.)
9. Traffic signal equipment
10. Disaster prevention / crime prevention equipment
11. Data-processing equipment
12. Applications of similar complexity or with reliability requirements comparable to the applications listed in the above

1. Scope

This specification applies to EPZ4532D900-9R0T of multi-layer ferrite chip bead.

2. Product Description and Identification (Part Number)

1) Description:
Ferrite Bead,4532,90Ohm@100MHz,0.004Ohm RDC, 9000mA.

2) Product Identification (Part Number)

EPZ 4532 D 900 -9R0 I
 ① ② ③ ④ ⑤ ⑥

| ① Type | |
|--------|------------------------|
| EPZ | For extra high current |

| ② External Dimensions(L X W) [mm] | |
|-----------------------------------|-----------|
| 4532 [1812] | 4.5 X 3.2 |

| ③ Material Code | |
|-----------------|---|
| | D |

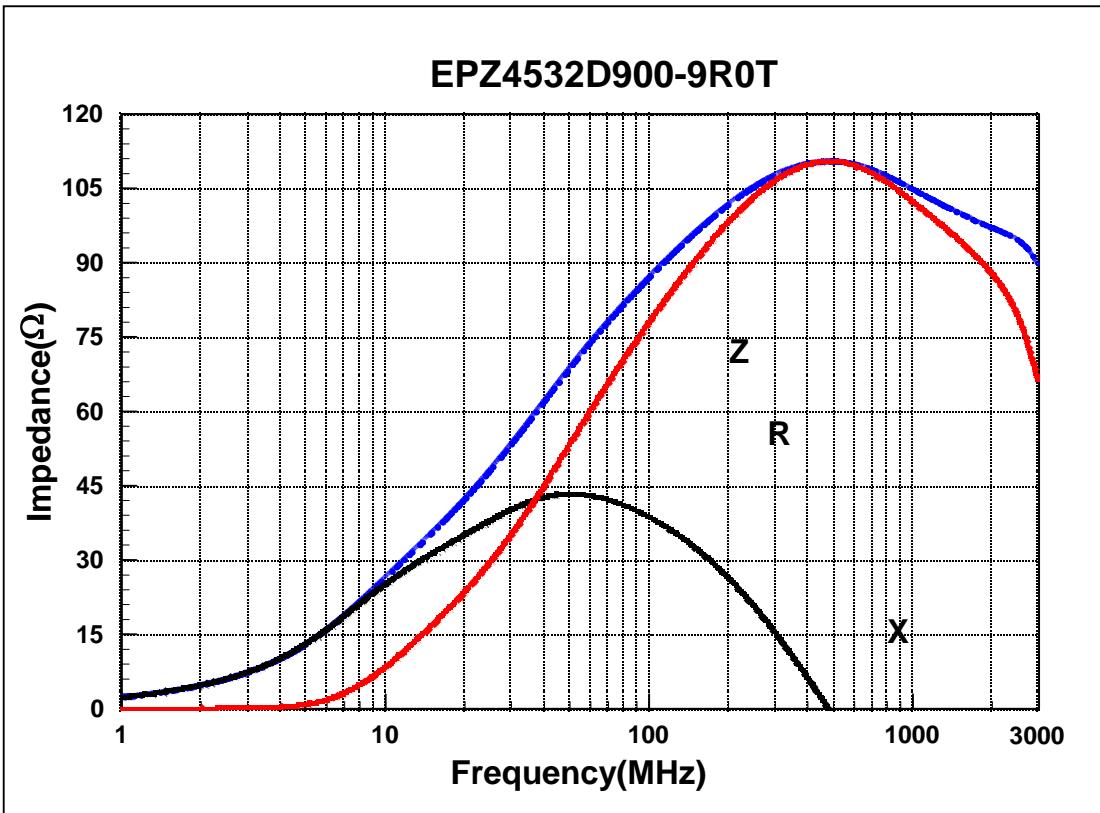
| ④ Nominal Impedance | |
|---------------------|---------------|
| Example | Nominal Value |
| 900 | 90Ω |

| ⑥ Packing | |
|-----------|----------------------|
| T | Tape Carrier Package |

3. Electrical Characteristics

| Part Number | Impedance (Ω) | Z Test Freq. (MHz) | DCR (mΩ) Max. | Ir (mA) Max. |
|------------------|---------------|--------------------|---------------|--------------|
| EPZ4532D900-9R0T | 90±25% | 100 | 4 | 9000 |

Impedance Frequency Characteristics



- 1) Operating and storage temperature range (individual chip without packing): -55°C ~ +125°C
- 2) Storage temperature range (packaging conditions): -10°C~+40°C and RH 70% (Max.)

4. Shape and Dimensions

- 1) Dimensions and recommended PCB pattern for reflow soldering: See **Fig.4-1**, **Fig.4-2** and **Table 4-1**.
- 2) Structure: See **Fig. 4-3** and **Fig. 4-4**.

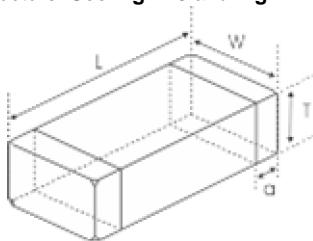
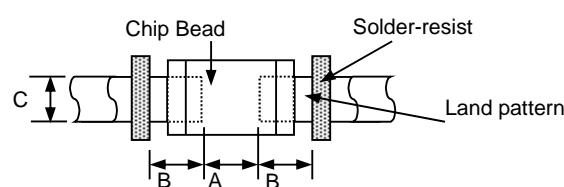


Fig. 4-1



[Table 4-1]

Unit: mm [inch]

| Type | L | W | T | a | A | B | C |
|----------------|-------------------------|-------------------------|--------------------------|--------------------------|---------|---------|---------|
| 4532 [1812] | 4.5±0.2 [0.18±0.008] | 3.2±0.2 [0.12±0.008] | 1.5±0.2 [0.060±0.008] | 0.5±0.3 [0.031±0.012] | 2.8~3.0 | 1.5~1.8 | 3.3~3.6 |

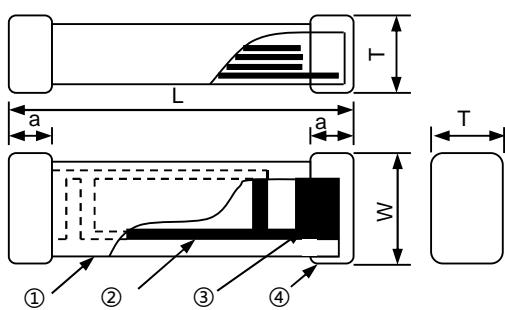


Fig. 4-3

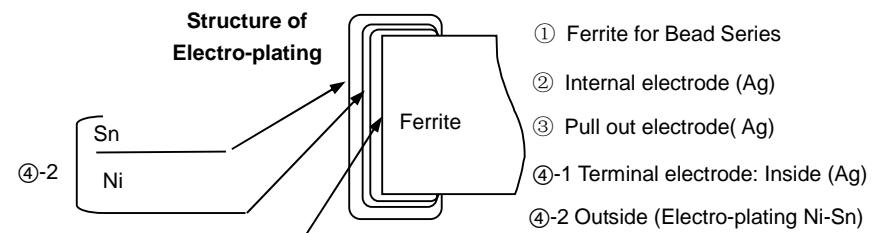


Fig. 4-4

- 3) Material Information: See **Table 4-2**.

[Table 4-2]

| Code | Part Name | Material Name |
|------|--------------------------------|--------------------------------|
| ① | Ferrite Body | Ferrite Powder |
| ② | Inner Coils | Silver Paste |
| ③ | Pull-out Electrode (Ag) | Silver Paste |
| ④-1 | Terminal Electrode: Inside Ag | Termination Silver Composition |
| ④-2 | Electro-Plating: Ni/Sn plating | Plating Chemicals |

5. Test and Measurement Procedures

5.1 Test Conditions

Unless otherwise specified, the standard atmospheric conditions for measurement/test as:

- a. Ambient Temperature: 20±15°C
- b. Relative Humidity: 65±20%
- c. Air Pressure: 86kPa to 106kPa

If any doubt on the results, measurements/tests should be made within the following limits:

- a. Ambient Temperature: 20±2°C
- b. Relative Humidity: 65±5%
- c. Air Pressure: 86kPa to 106kPa

5.2 Visual Examination

- a. Inspection Equipment: 20x magnifier

5.3 Electrical Test

5.3.1 DC Resistance (DCR)

- a. Refer to **Item 3..**
- b. Test equipment (Analyzer): High Accuracy Milliohmmeter-HP4338B or equivalent.

5.3.2 Impedance (Z)

- a. Refer to **Item 3..**
- b. Test equipment: High Accuracy RF Impedance /Material Analyzer-HP4291B or equivalent.

Test fixture: HP16192A; Test signal: -20dBm or 50mV

- c. Test frequency refers to **Item 3..**

5.3.3 Rated Current

- a. Refer to **Item 3..**
- b. Test equipment (see **Fig. 5.3.3-1**): Electric Power, Electric current meter, Thermometer.
- c. Measurement method (see **Fig. 5.3.3-1**):
 1. Set test current to be 0 mA.
 2. Measure initial temperature of chip surface.

3. Gradually increase voltage and measure chip temperature for corresponding current.

d. Definition of Rated Current (I_r): I_r is direct electric current as chip surface temperature raises just 20°C . against chip initial surface temperature(T_a). (see Fig. 5.3.3-2):

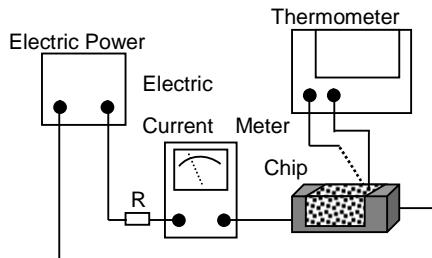


Fig. 5.3.3-1

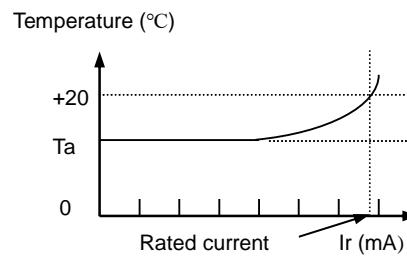
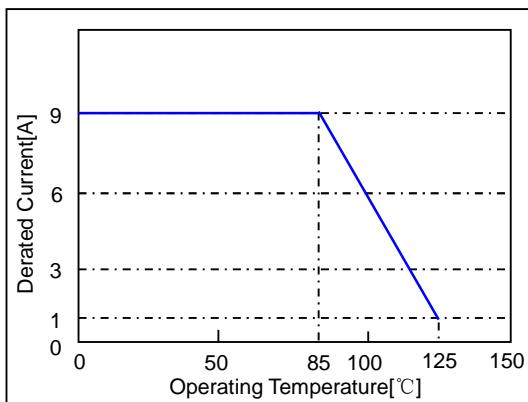
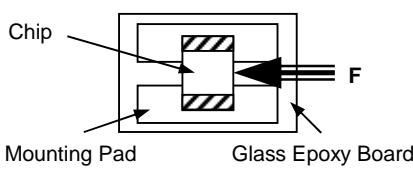
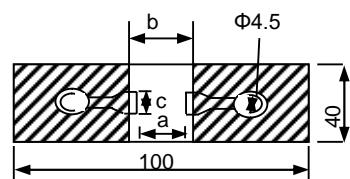
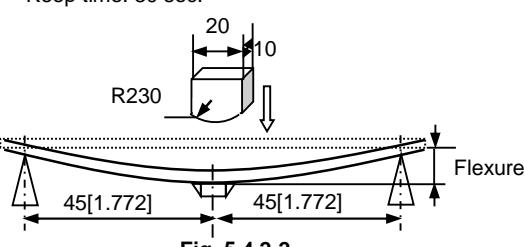
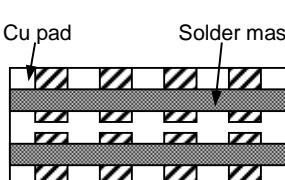
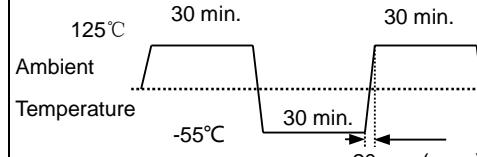


Fig. 5.3.3-2

e. In operating temperatures exceeding $+85^\circ\text{C}$, derating of current is necessary for chip ferrite beads for which rated current is 1000mA and over. Please apply the derating curve shown in chart according to the operating temperature.



5.4 Reliability Test

| Items | Requirements | Test Methods and Remarks | | | | | | | | |
|---------------------------------------|---|--|-----|---|---|------------|-----|-----|-----|--|
| 5.4.1 Terminal Strength | No removal or split of the termination or other defects shall occur.  Fig. 5.4.1-1 | <p>① Solder the bead to the testing jig (glass epoxy board shown in Fig. 5.4.1-1) using eutectic solder. Then apply a force in the direction of the arrow.</p> <p>② 10N force for 4532 series,</p> <p>③ Keep time: 10 ± 1s.</p> <p>④ Speed: 1.0mm/s.</p> | | | | | | | | |
| 5.4.2 Resistance to Flexure | No visible mechanical damage. Unit: mm [inch] <table border="1"> <thead> <tr> <th>Type</th><th>a</th><th>b</th><th>c</th></tr> </thead> <tbody> <tr> <td>4532[1812]</td><td>2.9</td><td>6.1</td><td>3.4</td></tr> </tbody> </table>  Fig. 5.4.2-1 | Type | a | b | c | 4532[1812] | 2.9 | 6.1 | 3.4 | <p>① Solder the bead to the test jig (glass epoxy board shown in Fig. 5.4.2-1) Using a eutectic solder. Then apply a force in the direction shown Fig. 5.4.2-2.</p> <p>② Flexure: 2mm.</p> <p>③ Pressurizing Speed: 0.5mm/sec.</p> <p>④ Keep time: 30 sec.</p>  Fig. 5.4.2-2 |
| Type | a | b | c | | | | | | | |
| 4532[1812] | 2.9 | 6.1 | 3.4 | | | | | | | |
| 5.4.3 Vibration | <p>① No visible mechanical damage.</p> <p>② Impedance change: within $\pm 20\%$.</p> | <p>① Solder the bead to the testing jig (glass epoxy board shown in Fig. 5.4.3-1) using eutectic solder.</p> <p>② The bead shall be subjected to a simple harmonic motion having total amplitude of 1.5mm, the frequency being varied uniformly between the approximate limits of 10 and 55 Hz.</p> <p>③ The frequency range from 10 to 55 Hz and return to 10 Hz shall be traversed in approximately 1 minute. This motion shall be applied for a period of 2 hours in each 3 mutually perpendicular directions (total of 6 hours).</p>  Fig. 5.4.3-1 | | | | | | | | |
| 5.4.4 Dropping | <p>① No visible mechanical damage.</p> <p>② Impedance change: within $\pm 20\%$.</p> | Drop chip bead 10 times on a concrete floor from a height of 100 cm. | | | | | | | | |
| 5.4.5 Temperature | Impedance change should be within $\pm 20\%$ of initial value measuring at 20°C. | Temperature range: $-55^\circ\text{C} \sim +125^\circ\text{C}$. Reference temperature: $+20^\circ\text{C}$. | | | | | | | | |
| 5.4.6 Solderability | <p>① No visible mechanical damage.</p> <p>② Wetting shall exceed 95% coverage.</p> | <p>① Solder temperature: $240\pm 2^\circ\text{C}$.</p> <p>② Duration: 3 sec.</p> <p>③ Solder: Sn/3.0Ag/0.5Cu.</p> <p>④ Flux: 25% Resin and 75% ethanol in weight.</p> | | | | | | | | |
| 5.4.7 Resistance to Soldering Heat | <p>① No visible mechanical damage.</p> <p>② Wetting shall exceed 95% coverage.</p> <p>③ Impedance change: within $\pm 20\%$.</p> | <p>① Solder temperature: $260\pm 3^\circ\text{C}$</p> <p>② Duration: 5 sec.</p> <p>③ Solder: Sn/3.0Ag/0.5Cu.</p> <p>④ Flux: 25% Resin and 75% ethanol in weight.</p> <p>⑤ The chip shall be stabilized at normal condition for 1~2 hours before measuring.</p> | | | | | | | | |
| 5.4.8 Thermal Shock | <p>① No mechanical damage.</p> <p>② Impedance change: Within $\pm 20\%$</p>  Fig. 5.4.8-1 | <p>① Temperature, Time: (See Fig. 5.4.8-1) -55°C for 30 ± 3 min $\rightarrow 125^\circ\text{C}$ for 30 ± 3 min</p> <p>② Transforming interval: Max. 20 sec.</p> <p>③ Tested cycle: 100 cycles.</p> <p>④ The chip shall be stabilized at normal condition for 1~2 hours before measuring.</p> | | | | | | | | |

| | | |
|--|---|--|
| 5.4.9 Resistance to Low Temperature | <ul style="list-style-type: none"> ① No mechanical damage. ② Impedance change: within $\pm 20\%$ | <ul style="list-style-type: none"> ① Temperature: $-55 \pm 2^\circ\text{C}$ ② Duration: 1000^{+24} hours. ③ The chip shall be stabilized at normal condition for 1~2 hours before measuring. |
| 5.4.10 Resistance to High Temperature | <ul style="list-style-type: none"> ① No mechanical damage. ② Impedance change: within $\pm 20\%$ | <ul style="list-style-type: none"> ① Temperature: $125 \pm 2^\circ\text{C}$. ② Duration: 1000^{+24} hours. ③ The chip shall be stabilized at normal condition for 1~2 hours before measuring. |
| 5.4.11 Damp Heat (Steady States) | <ul style="list-style-type: none"> ① No visible mechanical damage. ② Impedance change: within $\pm 20\%$ | <ul style="list-style-type: none"> ① Temperature: $60 \pm 2^\circ\text{C}$. ② Humidity: 90% to 95% RH. ③ Duration: 1000^{+24} hours. ④ The chip shall be stabilized at normal condition for 1~2 hours before measuring. |
| 5.4.12 Loading Under Damp Heat | <ul style="list-style-type: none"> ① No visible mechanical damage. ② Impedance change: within $\pm 20\%$ | <ul style="list-style-type: none"> ① Temperature: $60 \pm 2^\circ\text{C}$. ② Humidity: 90% to 95% RH. ③ Duration: 1000^{+24} hours. ④ Applied current: Rated current. ⑤ The chip shall be stabilized at normal condition for 1~2 hours before measuring. |
| 5.4.13 Loading at High Temperature (Life Test) | <ul style="list-style-type: none"> ① No visible mechanical damage. ② Impedance change: within $\pm 20\%$ | <ul style="list-style-type: none"> ① Temperature: $85 \pm 2^\circ\text{C}$ ② Duration: 1000^{+24} hours. ③ Applied current: Rated current. ④ The chip shall be stabilized at normal condition for 1~2 hours before measuring. |

6. Packaging and Storage

6.1 Packaging

Tape Carrier Packaging:

Packaging code: T

- a. Tape carrier packaging are specified in attached figure **Fig. 6.1-1~3**
- b. Tape carrier packaging quantity please see the following table:

| | |
|----------|---------------|
| Type | 4532[1812] |
| T(mm) | 1.5 ± 0.2 |
| Tape | Embossed Tape |
| Quantity | 2K |

(1) Taping Drawings (Unit: mm)

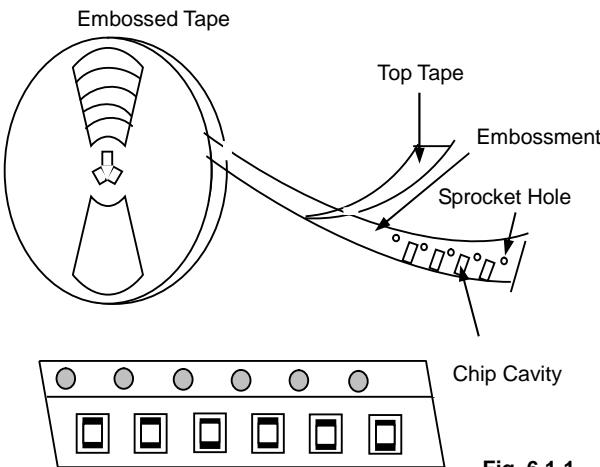
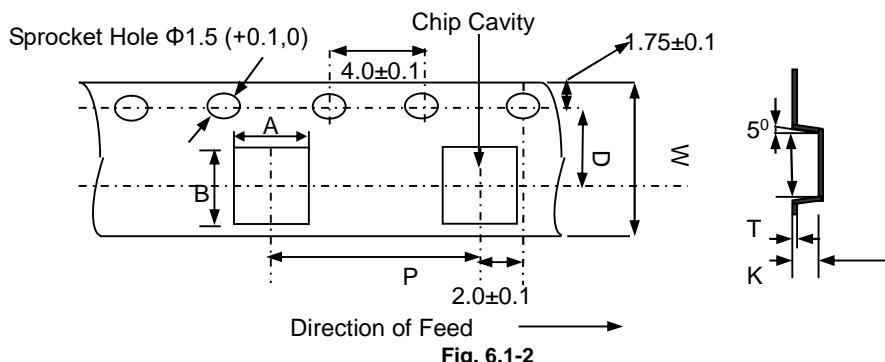


Fig. 6.1-1

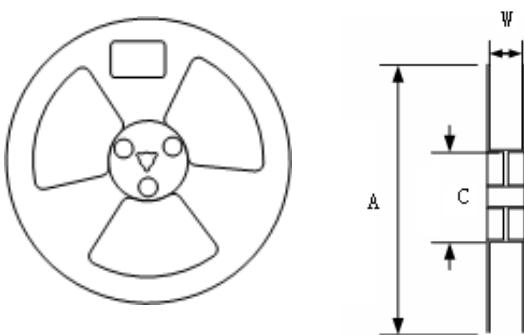
Remark: The sprocket holes are to the right as the tape is pulled toward the user.

(2) Taping Dimensions (Unit: mm)



| Type | A | B | P | D | W | K max | T max |
|------------|-----------|-----------|-----------|------------|----|-------|-------|
| 4532[1812] | 3.5 ± 0.1 | 4.8 ± 0.1 | 8.0 ± 0.1 | 5.5 ± 0.05 | 12 | 2.70 | 0.33 |

(3) Reel Dimensions (Unit: mm)



| Type | Spec. | Dimensions(mm) | | |
|------------|------------|----------------|---------------|-----|
| | | A | W | C |
| 4532[1812] | 13" * 12mm | 330 | 12.5 +2.0/-0. | 100 |

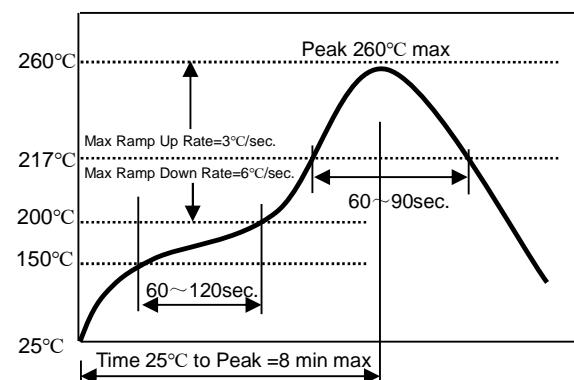
6.2 Storage

- The solderability of the external electrode may be deteriorated if packages are stored where they are exposed to high humidity. Package must be stored at 40°C or less and 70% RH or less.
- The solderability of the external electrode may be deteriorated if packages are stored where they are exposed to dust of harmful gas (e.g. HCl, sulfurous gas of H₂S).
- Packaging material may be deformed if package are stored where they are exposed to heat of direct sunlight.
- Solderability specified in **Clause 5.4.6** shall be guaranteed for 12 months from the date of delivery on condition that they are stored at the environment specified in **Clause 3**. For those parts, which passed more than 12 months shall be checked solder-ability before use.

7. Recommended Soldering Technologies**7.1 Re-flowing Profile:**

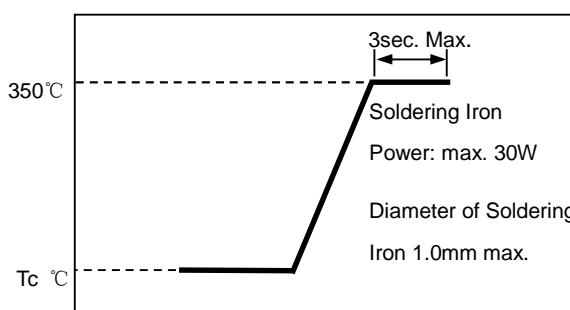
- △ Preheat condition: 150 ~200°C/60~120sec.
- △ Allowed time above 217°C: 60~90sec.
- △ Max temp: 260°C
- △ Max time at max temp: 10sec.
- △ Solder paste: Sn/3.0Ag/0.5Cu
- △ Allowed Reflow time: 2x max

[Note: The reflow profile in the above table is only for qualification and is not meant to specify board assembly profiles. Actual board assembly profiles must be based on the customer's specific board design, solder paste and process, and should not exceed the parameters as the Reflow profile shows.]

**7.2 Iron Soldering Profile.**

- △ Iron soldering power: Max. 30W
- △ Pre-heating: 150°C/60sec.
- △ Soldering Tip temperature: 350°C Max.
- △ Soldering time: 3sec. Max.
- △ Solder paste: Sn/3.0Ag/0.5Cu
- △ Max. 1 times for iron soldering

[Note: Take care not to apply the tip of the soldering iron to the terminal electrodes.]



8. Supplier Information

a) Supplier:

Shenzhen Sunlord Electronics Co., Ltd.

b) Manufacturer:

Shenzhen Sunlord Electronics Co., Ltd.

c) Manufacturing Address:

Sunlord Industrial Park, Dafuyuan Industrial Zone, Guanlan, Shenzhen, China 518110